16M x 16 bit DDR Synchronous DRAM (SDRAM)

Etron Confidential

(Rev. 0.7 July/ 2008)

Features

Fast clock rate: 250/200MHz
Differential Clock CK & CK

Bi-directional DQS

• DLL enable/disable by EMRS

• Fully synchronous operation

• Internal pipeline architecture

• Four internal banks, 4M x 16-bit for each bank

Programmable Mode and Extended Mode registers

- CAS Latency: 3 - Burst length: 2, 4, 8

- Burst Type: Sequential & Interleaved

• Individual byte write mask control

• DM Write Latency = 0

· Auto Refresh and Self Refresh

• 8192 refresh cycles / 64ms

• Precharge & active power down

• Power supplies:

 $VDD = 2.5V \pm 5\%$

 $VDDQ = 2.5V \pm 5\%$

• Interface: SSTL 2 I/O Interface

• Package: 66 Pin TSOP II, 0.65mm pin pitch

- Pb and Halogen free

Overview

The EM6AA160 SDRAM is a high-speed CMOS double data rate synchronous DRAM containing 256 Mbits. It is internally configured as a quad 4M x 16 DRAM with a synchronous interface (all signals are registered on the positive edge of the clock signal, CK). Data outputs occur at both rising edges of CK and CK d Read and write accesses to the SDRAM are burst oriented; accesses start at a selected location and continue for a programmed number of locations in a programmed sequence. Accesses begin with the registration of a BankActivate command which is then followed by a Read or Write command. The EM6AA160 provides programmable Read or Write burst lengths of 2, 4, or 8. An auto precharge function may be enabled to provide a self-timed row precharge that is initiated at the end of the burst sequence. The refresh functions, either Auto or Self Refresh are easy to use. In addition, EM6AA160 features programmable DLL option. By having a programmable mode register and extended mode register, the system can choose the most suitable modes to maximize its performance. These devices are well suited for applications requiring high memory bandwidth, result in a device particularly well suited to high performance main memory and graphics applications.

Table 1. Ordering Information

Part Number	Clock Frequency	Data Rate	Power Supply	Package
EM6AA160TS-4G	250MHz	500Mbps/pin	VDD 2.5V VDDQ 2.5V	TSOPII
EM6AA160TS-5G	200MHz	400Mbps/pin	VDD 2.5V VDDQ 2.5V	TSOPII

TS: indicates TSOPII package
G: indicates Pb and Halogen free

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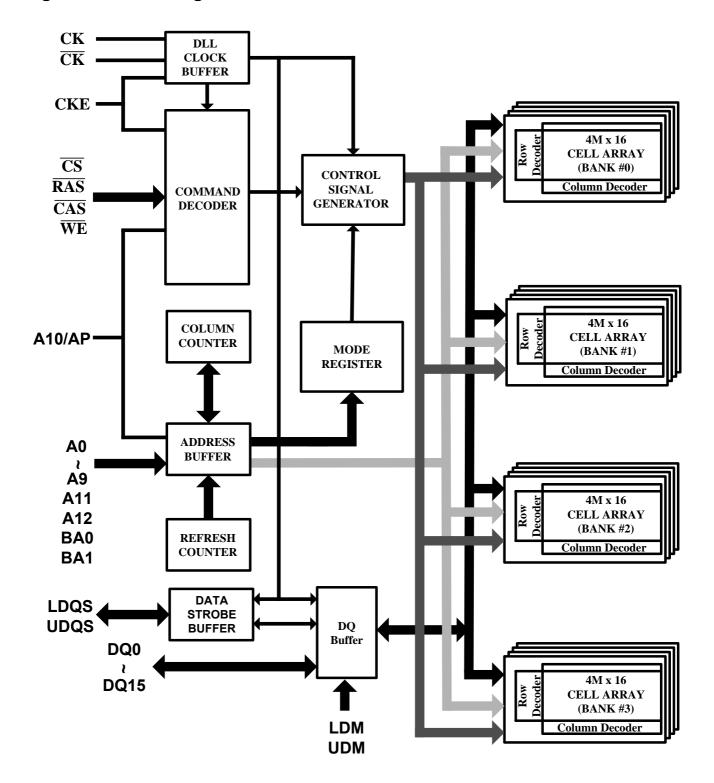
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Figure 1. Pin Assignment (Top View)

1			1
VDD	10	66	VSS VSS
DQ0	2	65	DQ15
VDDQ	3	64	☐ VSSQ
DQ1	4	63	DQ14
DQ2	5	62	DQ13
vssq 🗀	6	61	☐ VDDQ
DQ3	7	60	DQ12
DQ4	8	59	DQ11
VDDQ	9	58	☐ VSSQ
DQ5	10	57	DQ10
DQ6	11	56	DQ9
vssq 🗀	12	55	☐ VDDQ
DQ7	13	54	DQ8
NC	14	53	☐ NC
VDDQ	15	52	VSSQ VSSQ
LDQS	16	51	UDQS
NC	17	50	☐ NC
VDD	18	49	☐ VREF
NC	19	48	□ vss
LDM	20	47	UDM
WE	21	46	CK
CAS	22	45	🔲 ск
RAS	23	44	CKE
cs \square	24	43	☐ NC
NC	25	42	A12
вао 🗀	26	41	A11
ВА1	27	40	A9
A10/AP	28	39	A8
A0	29	38	A7
A1	30	37	A6
A2	31	36	A5
А3 🗔	32	35	☐ A4
VDD	33	34	□ vss
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Figure 2. Block Diagram



Pin Descriptions

Table 2. Pin Details of EM6AA160

Symbol	Туре	Description
CK, CK	Input	Differential Clock: CK, $\overline{\text{CK}}$ are driven by the system clock. All SDRAM input signals are sampled on the positive edge of CK. Both CK and $\overline{\text{CK}}$ increment the internal burst counter and controls the output registers.
CKE	Input	Clock Enable: CKE activates (HIGH) and deactivates (LOW) the CK signal. If CKE goes low synchronously with clock, the internal clock is suspended from the next clock cycle and the state of output and burst address is frozen as long as the CKE remains low. When all banks are in the idle state, deactivating the clock controls the entry to the Power Down and Self Refresh modes.
BA0, BA1	Input	Bank Activate: BA0 and BA1 define to which bank the BankActivate, Read, Write, or BankPrecharge command is being applied.
A0-A12	Input	Address Inputs: A0-A12 are sampled during the BankActivate command (row address A0-A12) and Read/Write command (column address A0-A8 with A10 defining Auto Precharge).
<u>CS</u>	Input	Chip Select: $\overline{\text{CS}}$ enables (sampled LOW) and disables (sampled HIGH) the command decoder. All commands are masked when $\overline{\text{CS}}$ is sampled HIGH. $\overline{\text{CS}}$ provides for external bank selection on systems with multiple banks. It is considered part of the command code.
RAS	Input	Row Address Strobe: The \overline{RAS} signal defines the operation commands in conjunction with the \overline{CAS} and \overline{WE} signals and is latched at the positive edges of CK. When \overline{RAS} and \overline{CS} are asserted "LOW" and \overline{CAS} is asserted "HIGH," either the BankActivate command or the Precharge command is selected by the \overline{WE} signal. When the \overline{WE} is asserted "HIGH," the BankActivate command is selected and the bank designated by BA is turned on to the active state. When the \overline{WE} is asserted "LOW," the Precharge command is selected and the bank designated by BA is switched to the idle state after the precharge operation.
CAS	Input	Column Address Strobe: The \overline{CAS} signal defines the operation commands in conjunction with the \overline{RAS} and \overline{WE} signals and is latched at the positive edges of CK. When \overline{RAS} is held "HIGH" and \overline{CS} is asserted "LOW," the column access is started by asserting \overline{CAS} "LOW." Then, the Read or Write command is selected by asserting \overline{WE} "HIGH" or "LOW".
WE	Input	Write Enable: The $\overline{\rm WE}$ signal defines the operation commands in conjunction with the $\overline{\rm RAS}$ and $\overline{\rm CAS}$ signals and is latched at the positive edges of CK. The $\overline{\rm WE}$ input is used to select the BankActivate or Precharge command and Read or Write command.
LDQS,	Input /	Bidirectional Data Strobe: Specifies timing for Input and Output data. Read Data
UDQS	Output	Strobe is edge triggered. Write Data Strobe provides a setup and hold time for data and DQM. LDQS is for DQ0~7, UDQS is for DQ8~15.
LDM, UDM	Input	Data Input Mask: Input data is masked when DM is sampled HIGH during a write cycle. LDM masks DQ0-DQ7, UDM masks DQ8-DQ15.
DQ0 - DQ15	Input / Output	Data I/O: The DQ0-DQ15 input and output data are synchronized with the positive edges of CK and $\overline{\text{CK}}$ The I/Os are byte-maskable during Writes.
V_{DD}	Supply	Power Supply: 2.5V ± 5%.
Vss	Supply	Ground

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V _{DDQ}	Supply	DQ Power: 2.5V ± 5% Provide isolated power to DQs for improved noise immunity.
Vssq	Supply	DQ Ground: Provide isolated ground to DQs for improved noise immunity.
VREF	Supply	Reference Voltage for Inputs: +0.5*VDDQ
NC	-	No Connect: These pins should be left unconnected.

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Operation Mode

Fully synchronous operations are performed to latch the commands at the positive edges of CK. Table 3 shows the truth table for the operation commands.

Table 3. Truth Table (Note (1), (2))

		1			1		1	1				
Command	State	CKE _{n-1}	CKEn	UDM	LDM	BA0,1	A 10	A0-9, 11-12	CS	RAS	CAS	WE
BankActivate	Idle ⁽³⁾	Н	Х	Χ	Х	٧	Rov	w address	L	L	Н	Н
BankPrecharge	Any	Н	Х	Χ	Х	V	L	Х	L	L	Н	L
PrechargeAll	Any	Н	Х	Х	Х	Х	Н	Х	L	L	Н	L
Write	Active ⁽³⁾	Н	Х	Х	Х	V	L	Column	L	Н	L	L
Write and AutoPrecharge	Active ⁽³⁾	Н	Х	Х	Х	V	Н	address (A0 ~ A8)	L	Н	L	L
Read	Active ⁽³⁾	Н	Х	Х	Х	V	L	Column	L	Н	L	Н
Read and Autoprecharge	Active ⁽³⁾	Н	Х	Χ	Х	V	Н	address (A0 ~ A8)	L	Н	L	Н
Mode Register Set	ldle	Н	Х	Х	Х		OP (code	L	L	L	L
Extended MRS	ldle	Н	Х	Х	Х		OP (code	L	L	L	L
No-Operation	Any	Н	Х	Χ	Х	Х	Х	Х	L	Н	Н	Н
Burst Stop	Active ⁽⁴⁾	Н	Х	Х	Х	Х	Х	Х	L	Н	Н	L
Device Deselect	Any	Н	Х	Х	Х	Х	Х	Х	Н	Х	Х	Χ
AutoRefresh	ldle	Н	Н	Х	Х	Х	Х	Х	L	L	L	Н
SelfRefresh Entry	ldle	Н	L	Х	Х	Х	Х	Х	L	L	L	Н
SelfRefresh Exit	Idle	L	Н	Х	Х	Х	Х	Х	Н	Х	Х	Χ
	(SelfRefresh)								L	Н	Н	Н
Precharge Power Down Mode	Idle	Н	L	Х	Х	Х	Х	Х	Н	Х	Х	Χ
Entry									L	Н	Н	Н
Precharge Power Down Mode	Any	L	Н	Х	Х	Х	Х	Х	Н	Χ	Х	Χ
Exit	(PowerDown)								L	Н	Н	Н
Active Power Down Mode	Active	Н	L	Х	Х	Х	Х	Х	Н	Х	Х	Χ
Entry									L	V	V	V
Active Power Down Mode	Any	L	Н	Х	Х	Х	Х	Х	Н	Х	Х	Х
Exit	(PowerDown)								L	Н	Н	Н
Data Input Mask Disable	Active	Н	Х	L	L	Х	Х	Х	Χ	Х	Х	Х
Data Input Mask Enable(5)	Active	Н	Х	Н	Н	Х	Х	Х	Χ	Х	Х	Х

- **Note:** 1. V=Valid data, X=Don't Care, L=Low level, H=High level
 - 2. CKEn signal is input level when commands are provided. CKE_{n-1} signal is input level one clock cycle before the commands are provided.
 - 3. These are states of bank designated by BA signal.
 - 4. Device state is 2, 4, and 8 burst operation.
 - 5. LDM and UDM can be enable respectively.

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Mode Register Set (MRS)

The mode register is divided into various fields depending on functionality.

• Burst Length Field (A2~A0)

This field specifies the data length of column access using the A2~A0 pins and selects the Burst Length to be 2, 4, 8.

Table 4. Burst Length

A2	A1	A0	Burst Length
0	0	0	Reserved
0	0	1	2
0	1	0	4
0	1	1	8
1	0	0	Reserved
1	0	1	Reserved
1	1	0	Reserved
1	1	1	Reserved

Addressing Mode Select Field (A3)

The Addressing Mode can be one of two modes, either Interleave Mode or Sequential Mode. Both Sequential Mode and Interleave Mode support burst length of 2, 4 and 8.

Table 5. Addressing Mode

А3	Addressing Mode
0	Sequential
1	Interleave

• Burst Definition, Addressing Sequence of Sequential and Interleave Mode

Table 6. Burst Address ordering

Puret Length	Sta	rt Addr	ess	Seguential	Interleave
Burst Length	A2	A1	A0	Sequential	Interieave
2	Х	Χ	0	0, 1	0, 1
	Х	Χ	1	1, 0	1, 0
	Χ	0	0	0, 1, 2, 3	0, 1, 2, 3
4	Χ	0	1	1, 2, 3, 0	1, 0, 3, 2
4	Χ	1	0	2, 3, 0, 1	2, 3, 0, 1
	Χ	1	1	3, 0, 1, 2	3, 2, 1, 0
	0	0	0	0, 1, 2, 3, 4, 5, 6, 7	0, 1, 2, 3, 4, 5, 6, 7
	0	0	1	1, 2, 3, 4, 5, 6, 7, 0	1, 0, 3, 2, 5, 4, 7, 6
	0	1	0	2, 3, 4, 5, 6, 7, 0, 1	2, 3, 0, 1, 6, 7, 4, 5
8	0	1	1	3, 4, 5, 6, 7, 0, 1, 2	3, 2, 1, 0, 7, 6, 5, 4
0	1	0	0	4, 5, 6, 7, 0, 1, 2, 3	4, 5, 6, 7, 0, 1, 2, 3
	1	0	1	5, 6, 7, 0, 1, 2, 3, 4	5, 4, 7, 6, 1, 0, 3, 2
	1	1	0	6, 7, 0, 1, 2, 3, 4, 5	6, 7, 4, 5, 2, 3, 0, 1
	1	1	1	7, 0, 1, 2, 3, 4, 5, 6	7, 6, 5, 4, 3, 2, 1, 0

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CAS Latency Field (A6~A4)

This field specifies the number of clock cycles from the assertion of the Read command to the first read data. The minimum whole value of CAS Latency depends on the frequency of CK. The minimum whole value satisfying the following formula must be programmed into this field. $t_{CAC}(min) \leq CAS \ Latency \ X \ t_{CK}$

Table 7. CAS Latency

A6	A5	A4	CAS Latency
0	0	0	Reserved
0	0	1	Reserved
0	1	0	Reserved
0	1	1	3 clocks
1	0	0	Reserved
1	0	1	Reserved
1	1	0	Reserved
1	1	1	Reserved

Test Mode field (A8~A7)

These two bits are used to enter the test mode and must be programmed to "00" in normal operation.

Table 8. Test Mode

/	48	A7	Test Mode	
	0	0	Normal mode	
	1	0	DLL Reset	

• (BA0, BA1)

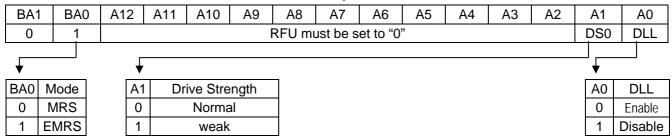
Table 9. MRS/EMRS

BA1	BA0	A12 ~ A0
RFU	0	MRS Cycle
RFU	1	Extended Functions (EMRS)

Extended Mode Register Set (EMRS)

The Extended Mode Register Set stores the data for enabling or disabling DLL and selecting output driver strength. The default value of the extended mode register is not defined, therefore must be written after power up for proper operation. The extended mode register is written by asserting low on \overline{CS} , \overline{RAS} , \overline{CAS} , and \overline{WE} . The state of A0 ~ A12, BA0 and BA1 is written in the mode register in the same cycle as \overline{CS} , \overline{RAS} , \overline{CAS} , and \overline{WE} going low. The DDR SDRAM should be in all bank precharge with CKE already high prior to writing into the extended mode register. A1 is used for setting driver strength to normal, or weak. Two clock cycles are required to complete the write operation in the extended mode register. The mode register contents can be changed using the same command and clock cycle requirements during operation as long as all banks are in the idle state. A0 is used for DLL enable or disable. "High" on BA0 is used for EMRS. Refer to the table for specific codes.

Table 10. Extended Mode Resistor Bitmap



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Table 11. Absolute Maximum Rating

Symbol	Item	Rating	Unit
VIN, VOUT	Input, Output Voltage	- 0.5~ V _{DD} + 0.5	V
V _{DD} , V _{DDQ}	Power Supply Voltage	- 0.5~3.7	V
TA	Ambient Temperature	0~70	°C
T _{STG}	Storage Temperature	- 65~150	°C
TSOLDER	Soldering Temperature	260	°C
PD	Power Dissipation	1	W
Іоит	Short Circuit Output Current	50	mA

Note: Stress greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device.

Table 12. Recommended D.C. Operating Conditions (TA = 0 ~ 70 °C)

Parameter	Symbol	Min.	Max.	Unit	Note
Power Supply Voltage	V _{DD}	2.375	2.625	V	
Power Supply Voltage (for I/O Buffer)	V _{DDQ}	2.375	2.625	V	
Input Reference Voltage	V _{REF}	0.49*V _{DDQ}	0.51* V _{DDQ}	٧	
Input High Voltage (DC)	VIH (DC)	V _{REF} + 0.15	V _{DDQ} + 0.3	٧	
Input Low Voltage (DC)	V _{IL} (DC)	-0.3	VREF - 0.15	٧	
Termination Voltage	Vтт	VREF - 0.04	VREF + 0.04	٧	
Input Voltage Level, CLK and CLK inputs	VIN (DC)	-0.3	VDDQ + 0.3	V	
Input Different Voltage, CLK and CLK inputs	V _{ID} (DC)	-0.36	VDDQ + 0.6	٧	
Input leakage current	lı	-2	2	μΑ	
Output leakage current	loz	-5	5	μΑ	
Output High Voltage	Vон	V _{TT} + 0.76	-	V	Iон = -15.2 mA
Output Low Voltage	Vol	-	VTT – 0.76	V	IOL = +15.2 mA

Note: All voltages are referenced to Vss.

Table 13. Capacitance (VDD = 2.5V, f = 1MHz, TA = 25 °C)

Symbol	Parameter	Min.	Max.	Unit
Cin	Input Capacitance (except for CK pin)	2.5	3.5	pF
	Input Capacitance (CK pin)	2.5	3.5	pF
C _{I/O}	DQ, DQS, DM Capacitance		5.0	pF

Note: These parameters are guaranteed by design, periodically sampled and are not 100% tested

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Table 14. D.C.Characteristics (VDD = 2.5V \pm 5%, T_A = 0~70 °C)

Parameter & Test Condition		-4	-5 Unit		Note
		Max		Oilit	s
OPERATING CURRENT: One bank; Active-Precharge; tRC=tRC(min); tCK=tCK(min); DQ,DM and DQS inputs changing once per clock cycle; Address and control inputs changing once every two clock cycles.	IDD0	240	220	mA	
OPERATING CURRENT: One bank; Active-Read- Precharge; BL=4; CL=4; tRCDRD=4*tcκ; tRc=tRc(min); tcκ=tcκ(min); lout=0mA; Address and control inputs changing once per clock cycle	IDD1	270	250	mA	
PRECHARGE POWER-DOWN STANDBY CURRENT: All banks idle; power-down mode; tck=tck(min); CKE=LOW	IDD2P	40	40	mA	
IDLE STANDLY CURRENT: CKE = HIGH; \overline{\text{CS}} = HIGH(DESELECT); All banks idle; tck=tck(min); Address and control inputs changing once per clock cycle; VIN=VREF for DQ, DQS and DM	IDD2N	80	70	mA	
ACTIVE POWER-DOWN STANDBY CURRENT : one bank active; power-down mode; CKE=LOW; tcK=tcK(min)	IDD3P	65	55	mA	
ACTIVE STANDBY CURRENT: CS=HIGH; CKE=HIGH; one bank active; tRC=tRC(max);tCK=tCK(min);Address and control inputs changing once per clock cycle; DQ,DQS,and DM inputs changing twice per clock cycle	IDD3N	110	100	mA	
OPERATING CURRENT BURST READ: BL=2; READS; Continuous burst; one bank active; Address and control inputs changing once per clock cycle; tck=tck(min); lout=0mA;50% of data changing on every transfer	IDD4R	450	420	mA	
OPERATING CURRENT BURST Write: BL=2; WRITES; Continuous Burst; one bank active; address and control inputs changing once per clock cycle; tck=tck(min); DQ,DQS,and DM changing twice per clock cycle; 50% of data changing on every transfer	IDD4W	450	420	mA	
AUTO REFRESH CURRENT : tRC=tRFC(min); tCK=tCK(min)	IDD5	250	250	mA	
SELF REFRESH CURRENT: Sell Refresh Mode ; CKE 0.2V;tck=tck(min)	IDD6	5	5	mA	1

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Table 15.Electrical Characteristics and Recommended A.C.Operating Condition (VDD = $2.5V \pm 5\%$, T_A = $0 \sim 70$ °C)

	_	-4		-5				
Symbol	Parameter	Min Max		Min Max		Unit	Note	
t cĸ	Clock cycle time CL = 3	4	10	5	10	ns		
tсн	Clock high level width	0.45	0.55	0.45	0.55	tcĸ		
t CL	Clock low level width	0.45	0.55	0.45	0.55	tcĸ		
thp	Clock half period	tCLMIN or tCHMIN	-	tCLMIN or tCHMIN	-	ns	2	
tHZ	Data-out-high impedance time from CK, $\overline{\text{CK}}$	-0.7	0.7	-0.7	0.7	ns	3	
t∟z	Data-out-low impedance time from CK, $\overline{\text{CK}}$	-0.7	0.7	-0.7	0.7	ns	3	
tdqsck	DQS-out access time from CK, CK	-0.7	0.7	-0.7	0.7	ns		
tac	Output access time from CK, CK	-0.7	0.7	-0.7	0.7	ns		
toqsq	DQS-DQ Skew	-	0.4	-	0.45	ns		
trpre	Read preamble	0.9	1.1	0.9	1.1	tcĸ		
trpst	Read postamble	0.4	0.6	0.4	0.6	tcĸ		
togss	CK to valid DQS-in	0.8	1.2	0.8	1.2	tcĸ		
twpres	DQS-in setup time	0	-	0	-	ns	4	
twpre	DQS write preamble	0.35	-	0.35	-	tcĸ		
twpst	DQS write postamble	0.4	0.6	0.4	0.6	tcĸ	5	
tDQSH	DQS in high level pulse width	0.35	-	0.35	-	tcĸ		
toqsl	DQS in low level pulse width	0.35	-	0.35	-	tcĸ		
tıs	Address and Control input setup time	0.9	=	1.0	-	ns	6	
tıн	Address and Control input hold time	0.9	-	1.0	-	ns	6	
tos	DQ & DM setup time to DQS	0.45	-	0.45	-	ns		
tон	DQ & DM hold time to DQS	0.45	-	0.45	-	ns		
tqн	DQ/DQS output hold time from DQS	tHP -0.5	-	tHP -0.55	-	ns		
trc	Row cycle time	60	-	60	-	ns		
trfc	Refresh row cycle time	72	-	72	-	ns		
tras	Row active time	40	120K	40	120K	ns		
trcd	RAS to CAS Delay	20	-	20	-	ns		
trp	Row precharge time	20	-	20	-	ns		
trrd	Row active to Row active delay	8	-	10	-	ns		
twr	Write recovery time	12	-	15	-	ns		
twr	Internal Write to Read Command Delay	2	-	2	-	tcĸ		
tmrd	Mode register set cycle time	8	-	10	-	ns		
trefi	Average Periodic Refresh interval	-	7.8	-	7.8	μS	7	
txsrd	Self refresh exit to read command delay	200	-	200	-	tcĸ		
txsnr	Self refresh exit to non-read command delay	75	-	75	-	ns		
txpnr	Exit Power down to command	1	-	1	-	tcĸ		
txprd	Exit Power down to Read command	1	-	1	-	tcĸ	8	
tDAL	Auto Precharge write recovery + precharge time	36	-	35	-	ns		
tDIPW	DQ and DM input puls width	1.75	-	1.75	-	ns		

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Table 16. Recommended A.C. Operating Conditions (VDD = 2.5V ± 5%, TA = 0~70 °C)

Parameter	Symbol	Min.	Max.	Unit	Note
Input High Voltage (AC)	VIH (AC)	VREF + 0.35	-	V	
Input Low Voltage (AC)	V _{IL} (AC)	•	VREF - 0.35	V	
Input Different Voltage, CLK and CLK inputs	VID (AC)	0.7	VDDQ + 0.6	V	
Input Crossing Point Voltage, CLK and CLK	V _{IX} (AC)	0.5*VDDQ-0.2	0.5*VDDQ+0.2	V	
inputs					

Note:

- 1) Enables on-chip refresh and address counters.
- 2) Min (tcl, tch) refers to ther smaller of the actual clock low time and actual clock high time as provided to the device.
- 3) t_{HZ} and t_{LZ} transitions occur in the same access time windows as valid data transitions. These parameters are not referenced to a specific voltage level, but specify when the device output is no longer driving (HZ), or begins driving (LZ).
- 4) The specific requirement is that DQS be valid (High, Low, or at some point on a valid transition) on or before this CLK edge. A valid transition is defined as monotonic, and meeting the input slew rate specifications of the device. When no writes were previously in progress on the bus, DQS will be transitioning from High-Z to logic LOW. If a previous write was in progress, DQS could be HIGH, LOW, or transitioning from HIGH to LOW at this time, depending on tDQSS.
- 5) The maximum limit for this parameter is not a device limit. The device will operate with a greater value for this parameter, but system performance (bus turnaround) will degrade accordingly.
- 6) For command/address and CK & CK slew rate 1.0V/ns.
- 7) A maximum of eight AUTO REFRESH commands can be posted to any given DDR SDRAM device.
- 8) txprd should be 200 tck in the condition of the unstable CLK operation during the power down mode.

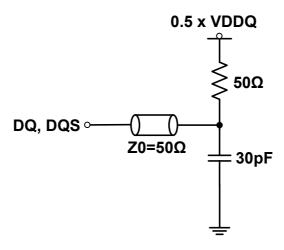
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A.C. Test Conditions

Table 17. SSTL _2 Interface

Reference Level of Output Signals (VREF)	0.5 * VDDQ
Output Load	Reference to the Under Output Load (A)
Input Signal Levels	V _{REF} +0.35 V / V _{REF} -0.35 V
Input Signals Slew Rate	1 V/ns
Reference Level of Input Signals	0.5 * VDDQ

Figure 3. SSTL_2 A.C. Test Load



Power up Sequence

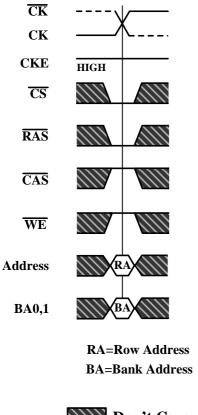
Power up must be performed in the following sequence.

- 1) Apply power to V_{DD} before or at the same time as V_{DDQ} , V_{TT} and V_{REF} when all input signals are held "NOP" state and maintain CKE "LOW".
- 2) Start clock and maintain stable condition for minimum $200\mu s$.
- 3) Issue a "NOP" command and keep CKE "HIGH"
- 4) Issue a "Precharge All" command.
- 5) Issue EMRS enable DLL.
- 6) Issue MRS reset DLL. (An additional 200 clock cycles are required to lock the DLL).
- 7) Precharge all banks of the device.
- 8) Issue two or more Auto Refresh commands.
- 9) Issue MRS with A8 to low to initialize the mode register.

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Timing Waveforms

Figure 4. Activating a Specific Row in a Specific Bank



Don't Care

Figure 5. tRCD and tRRD Definition

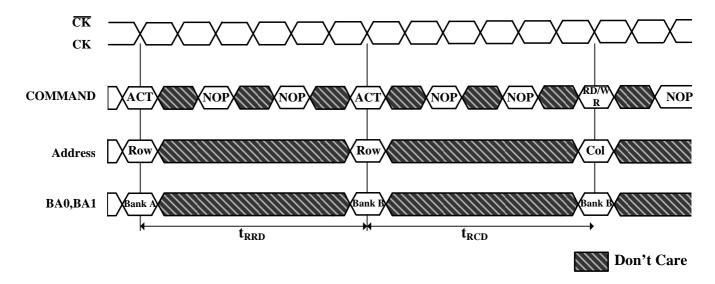
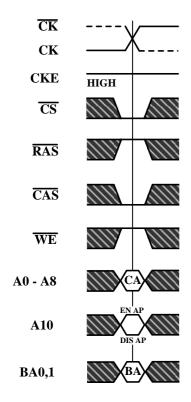


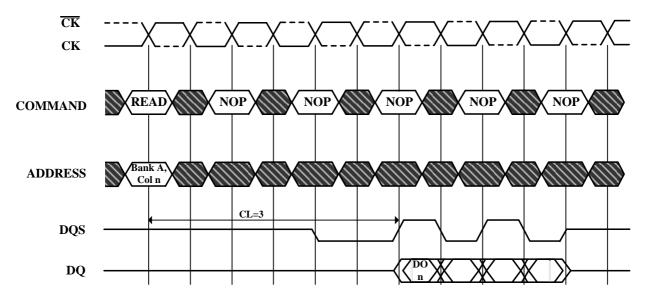
Figure 6. READ Command



CA=Column Address
BA=Bank Address
EN AP=Enable Autoprecharge
DIS AP=Disable Autoprecharge



Figure 7. Read Burst Required CAS Latencies (CL=3)



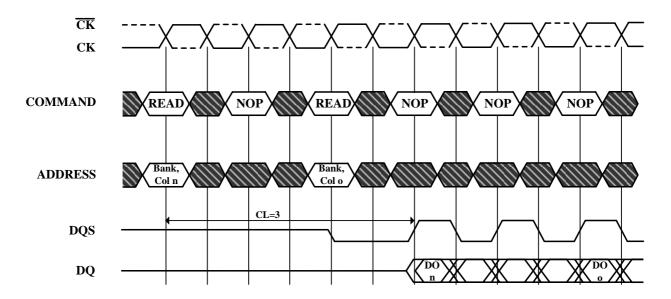
DO n=Data Out from column n

Burst Length=4

3 subsequent elements of Data Out appear in the programmed order following DO n



Figure 8. Consecutive Read Bursts Required CAS Latencies (CL=3)



DO n (or o)=Data Out from column n (or column o)

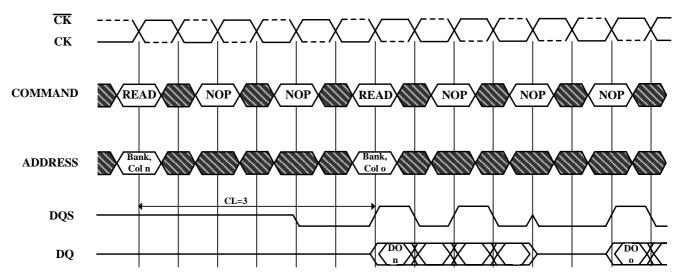
Burst Length=4 or 8 (if 4, the bursts are concatenated; if 8, the second burst interrupts the first)

3 subsequent elements of Data Out appear in the programmed order following DO n

 $3\ (or\ 7)$ subsequent elements of Data Out appear in the programmed order following DO o Read commands shown must be to the same device



Figure 9. Non-Consecutive Read Bursts Required CAS Latencies (CL=3)



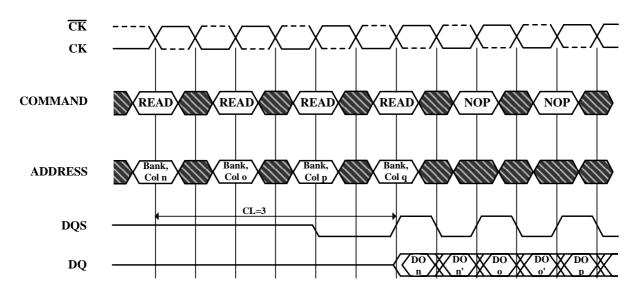
DO n (or o)=Data Out from column n (or column o)

Burst Length=4

3 subsequent elements of Data Out appear in the programmed order following DO n (and following DO $o)\,$



Figure 10. Random Read Accesses Required CAS Latencies (CL=3)

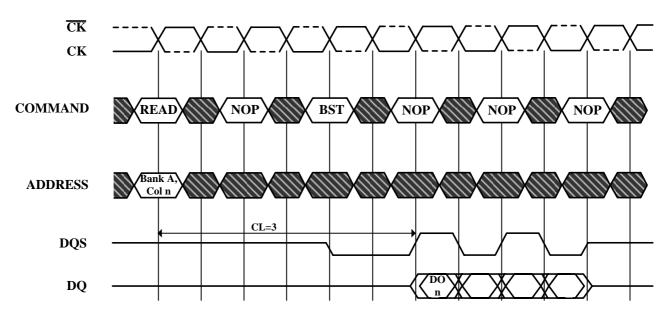


DO n, etc. =Data Out from column n, etc.

n', etc. =the next Data Out following DO n, etc. according to the programmed burst order Burst Length=2,4 or 8 in cases shown. If burst of 4 or 8, the burst is interrupted Reads are to active rows in any banks



Figure 11. Terminating a Read Burst Required CAS Latencies (CL=3)



DO n = Data Out from column n

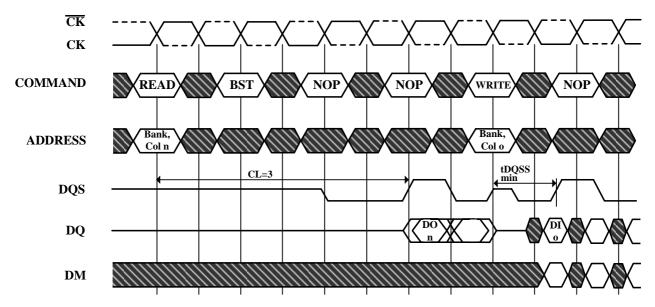
Cases shown are bursts of 8 terminated after 4 data elements

3 subsequent elements of Data Out appear in the programmed order following DO n



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Figure 12. Read to Write Required CAS Latencies (CL=3)



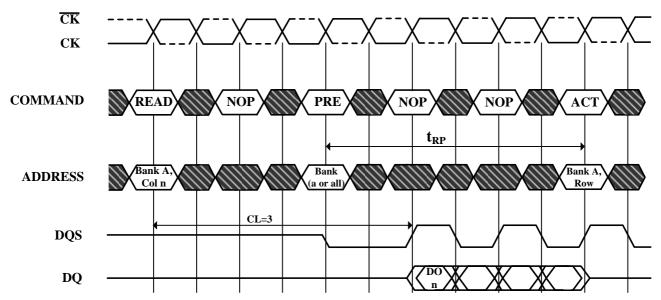
DO n (or o)= Data Out from column n (or column o)

Burst Length= 4 in the cases shown (applies for bursts of 8 as well; if burst length is 2, the BST command shown can be NOP)

1 subsequent element of Data Out appears in the programmed order following DO n Data in elements are applied following DI o in the programmed order



Figure 13. Read to Precharge Required CAS Latencies (CL=3)



DO n = Data Out from column n

Cases shown are either uninterrupted bursts of 4, or interrupted bursts of 8

 $\boldsymbol{3}$ subsequent elements of Data Out appear in the programmed order following DO \boldsymbol{n}

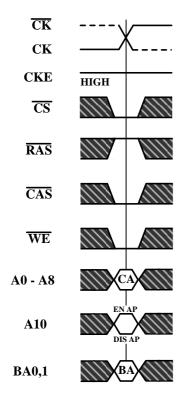
Precharge may be applied at (BL/2) tCK after the READ command

Note that Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks

The Active command may be applied if tRC has been met



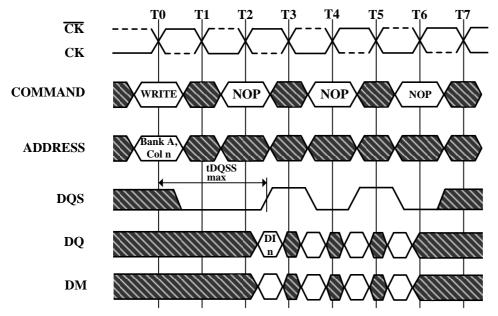
Figure 14. Write Command



CA=Column Address BA=Bank Address EN AP=Enable Autoprecharge DIS AP=Disable Autoprecharge



Figure 15. Write Max DQSS



DI n = Data In for column n

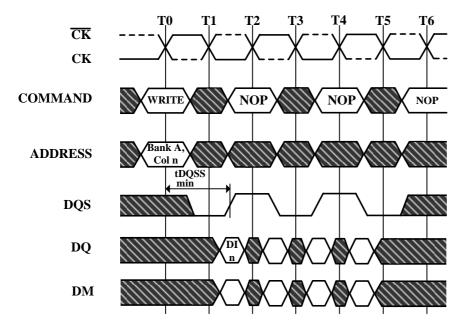
3 subsequent elements of Data In are applied in the programmed order following DI n

A non-interrupted burst of 4 is shown

 ${\bf A10~is~LOW~with~the~WRITE~command~(AUTO~PRECHARGE~disabled)}$



Figure 16. Write Min DQSS



DI n = Data In for column n

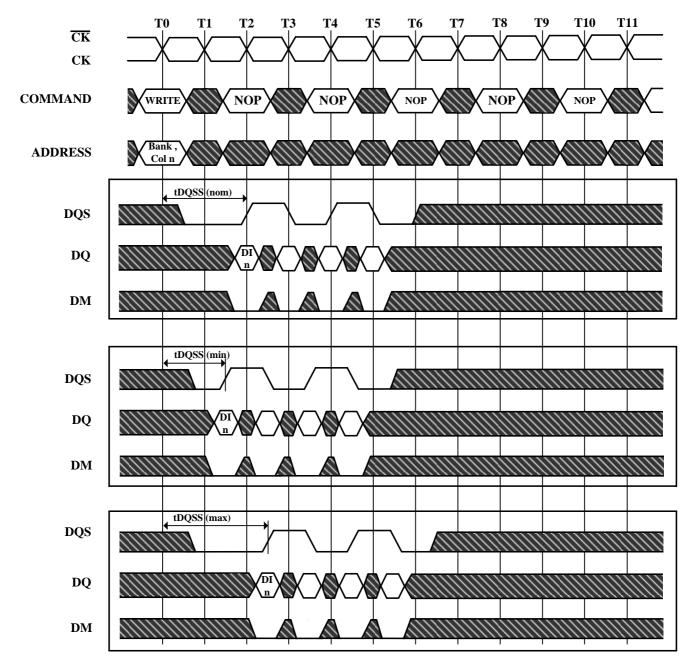
 ${\bf 3}$ subsequent elements of Data In are applied in the programmed order following DI ${\bf n}$

A non-interrupted burst of 4 is shown

A10 is LOW with the WRITE command (AUTO PRECHARGE disabled)



Figure 17. Write Burst Nom, Min, and Max tDQSS



DI n = Data In for column n

 $\boldsymbol{3}$ subsequent elements of Data $\,$ are applied in the programmed order following DI \boldsymbol{n}

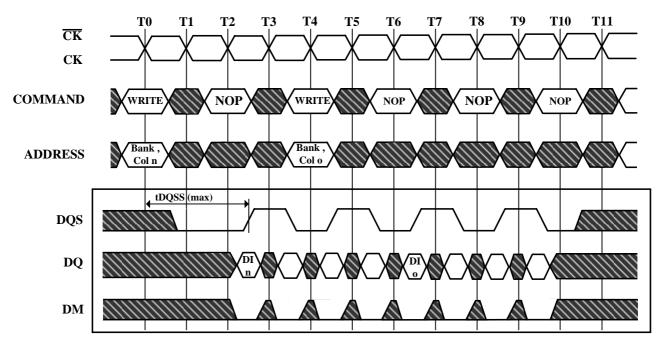
A non-interrupted burst of 4 is shown

A10 is LOW with the WRITE command (AUTO PRECHARGE disabled)

DM=UDM & LDM



Figure 18. Write to Write Max tDQSS



DI n, etc. = Data In for column n,etc.

3 subsequent elements of Data In are applied in the programmed order following DI n

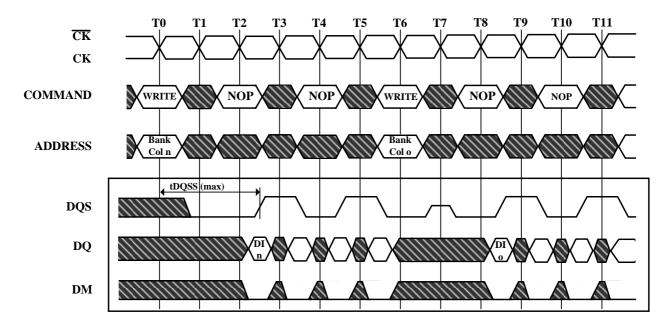
3 subsequent elements of Data In are applied in the programmed order following DI o

Non-interrupted bursts of 4 are shown

DM= UDM & LDM



Figure 19. Write to Write Max tDQSS, Non Consecutive



DI n, etc. = Data In for column n, etc.

3 subsequent elements of Data In are applied in the programmed order following DI n

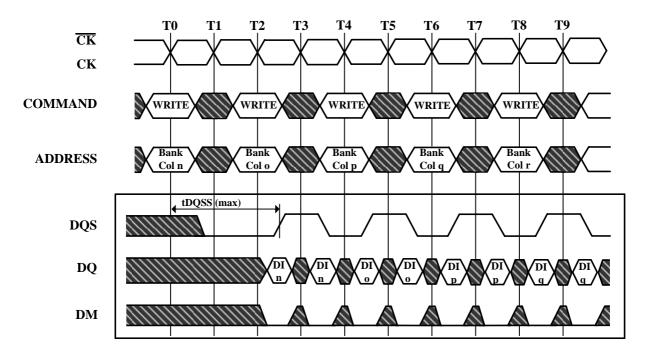
3 subsequent elements of Data In are applied in the programmed order following DI o

Non-interrupted bursts of 4 are shown

DM= UDM & LDM



Figure 20. Random Write Cycles Max tDQSS



DI n, etc. = Data In for column n, etc.

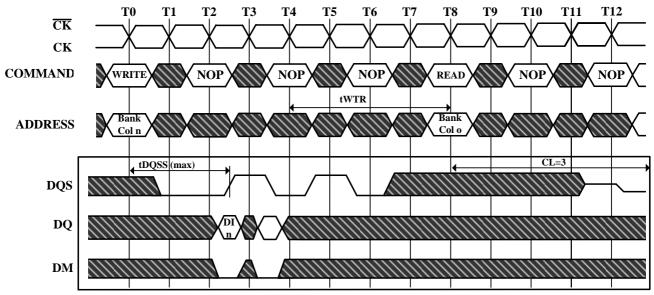
n', etc. = the next Data In following DI n, etc. according to the programmed burst order Programmed Burst Length 2, 4, or 8 in cases shown

If burst of 4 or 8, the burst would be truncated

Each WRITE command may be to any bank and may be to the same or different devices DM = UDM & LDM



Figure 21. Write to Read Max tDQSS Non Interrupting



DI n, etc. = Data In for column n, etc.

1 subsequent elements of Data In are applied in the programmed order following DI n

A non-interrupted burst of 4 is shown

tWTR is referenced from the first positive CK edge after the last Data In Pair

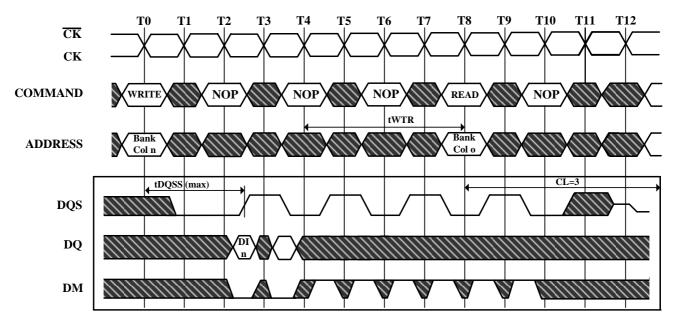
A10 is LOW with the WRITE command (AUTO PRECHARGE is disabled)

The READ and WRITE commands are to the same devices but not necessarily to the same bank

DM= UDM & LDM



Figure 22. Write to Read Max tDQSS Interrupting



DI n, etc. = Data In for column n, etc.

1 subsequent elements of Data In are applied in the programmed order following DI n

An interrupted burst of 8 is shown, 2 data elements are written

tWTR is referenced from the first positive CK edge after the last Data In Pair

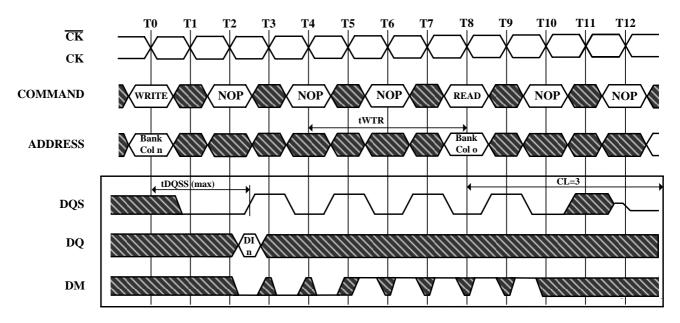
A10 is LOW with the WRITE command (AUTO PRECHARGE is disabled)

The READ and WRITE commands are to the same devices but not necessarily to the same bank

DM= UDM & LDM



Figure 23. Write to Read Max tDQSS, ODD Number of Data, Interrupting



DI n = Data In for column n

An interrupted burst of 8 is shown, 3 data elements are written

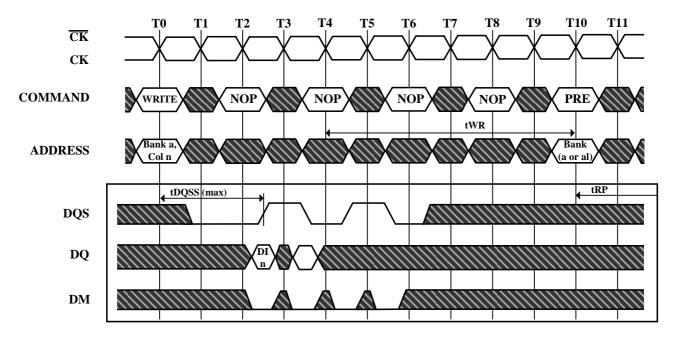
tWTR is referenced from the first positive CK edge after the last Data In Pair (not the last desired Data In element)

A10 is LOW with the WRITE command (AUTO PRECHARGE is disabled)

The READ and WRITE commands are to the same devices but not necessarily to the same bank DM= UDM & LDM



Figure 24. Write to Precharge Max tDQSS, NON-Interrupting



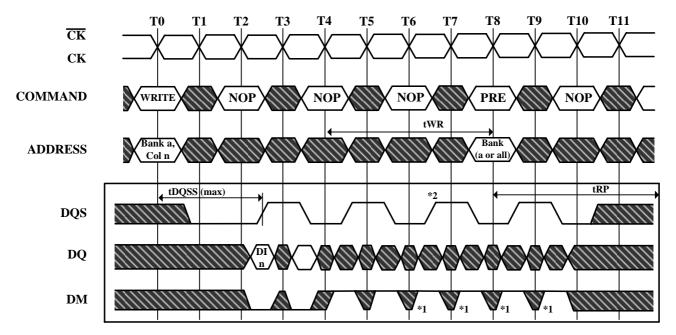
DI n = Data In for column n

 ${\bf 1}$ subsequent elements of Data $\,$ In are applied in the programmed order following DI n A non-interrupted burst of 4 is shown

tWR is referenced from the first positive CK edge after the last Data In Pair A10 is LOW with the WRITE command (AUTO PRECHARGE is disabled) DM= UDM & LDM



Figure 25. Write to Precharge Max tDQSS, Interrupting



DI n = Data In for column n

An interrupted burst of 4 or 8 is shown, 2 data elements are written tWR is referenced from the first positive CK edge after the last Data In Pair A10 is LOW with the WRITE command (AUTO PRECHARGE is disabled)

*1 = can be don't care for programmed burst length of 4

*2 = for programmed burst length of 4, DQS becomes don't care at this point DM= UDM & LDM

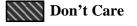
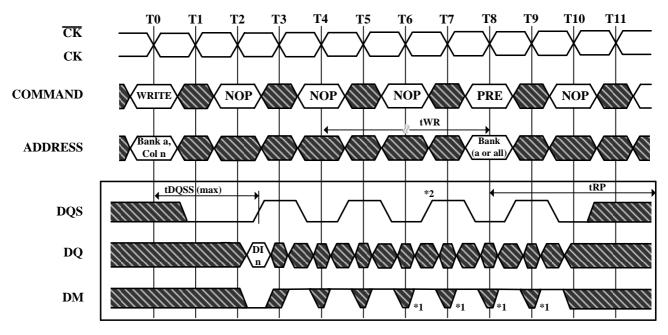


Figure 26. Write to Precharge Max tDQSS ODD Number of Data Interrupting



DI n = Data In for column n

An interrupted burst of 4 or 8 is shown, 1 data element is written

tWR is referenced from the first positive CK edge after the last Data In Pair

A10 is LOW with the WRITE command (AUTO PRECHARGE is disabled)

*1 = can be don't care for programmed burst length of 4

*2 = for programmed burst length of 4, DQS becomes don't care at this point

DM= UDM & LDM



Figure 27. Precharge Command

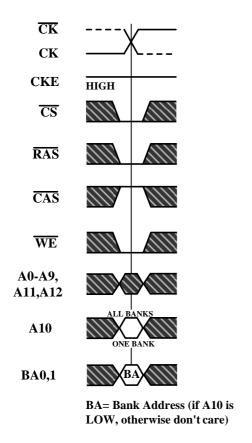




Figure 28. Power-Down

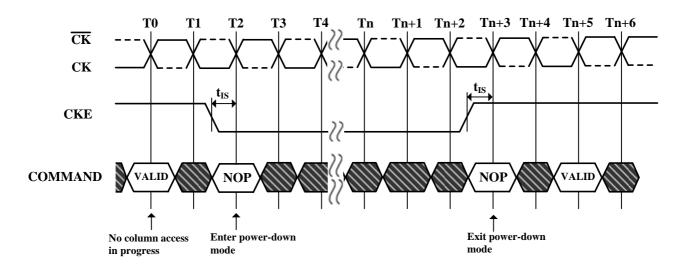
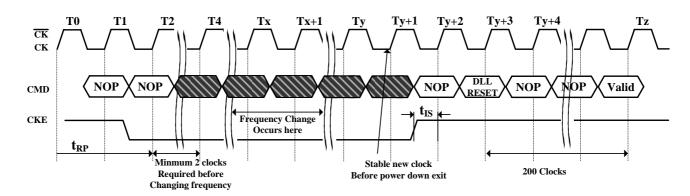


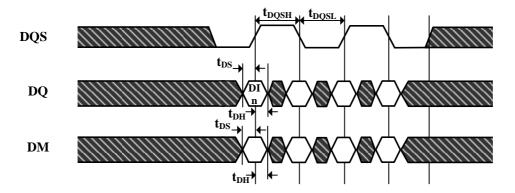


Figure 29. Clock Frequency Change in Precharge



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Figure 30. Data input (Write) Timing



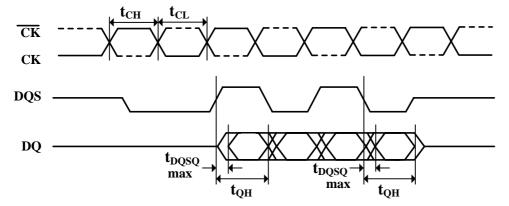
DI n = Data In for column n

Burst Length = 4 in the case shown

3 subsequent elements of Data In are applied in the programmed order following DI \boldsymbol{n}



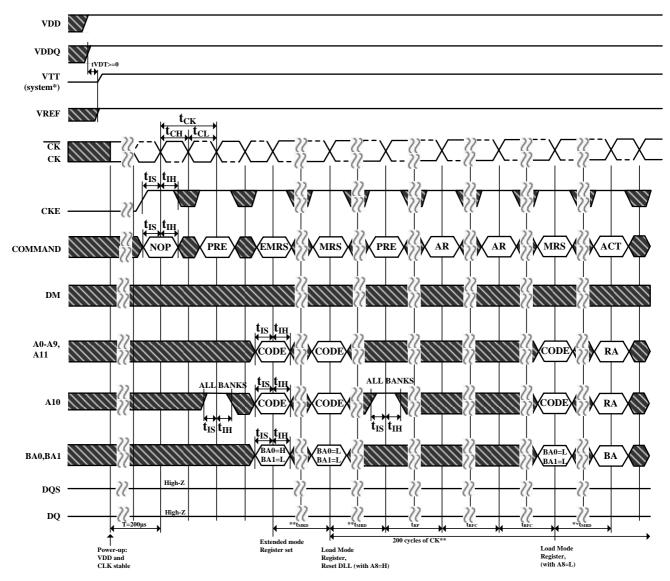
Figure 31. Data Output (Read) Timing



Burst Length = 4 in the case shown

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Figure 32. Initialize and Mode Register Sets



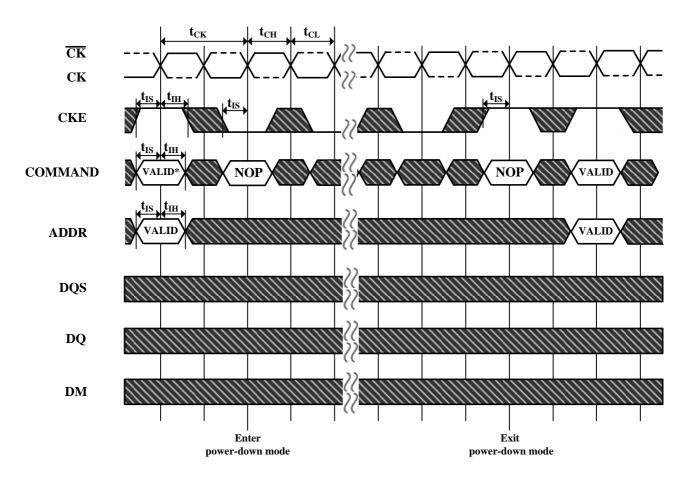
^{*=}VTT is not applied directly to the device, however tVTD must be greater than or equal to zero to avoid device latch-up

The two Auto Refresh commands may be moved to follow the first MRS but precede the second PRECHARGE ALL command



^{**=}tMRD is required before any command can be applied, and 200 cycles of CK are required before any executable command can be applied

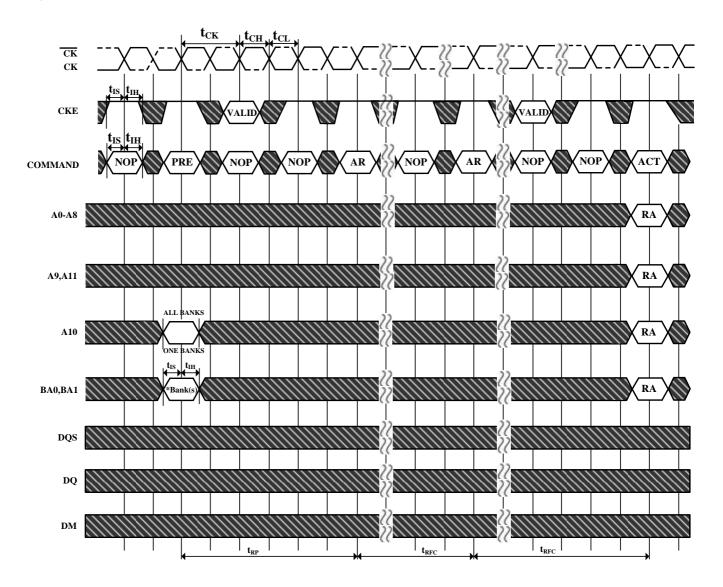
Figure 33. Power Down Mode



No column accesses are allowed to be in progress at the time Power-Down is entered *=If this command is a PRECHARGE ALL (or if the device is already in the idle state) then the Power-Down mode shown is Precharge Power Down. If this command is an ACTIVE (or if at least one row is already active) then the Power-Down mode shown is active Power Down.



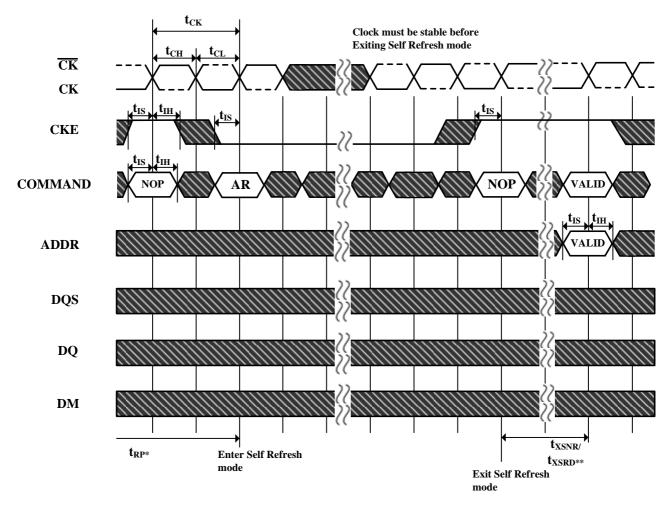
Figure 34. Auto Refresh Mode



*= Don't Care , if A10 is HIGH at this point; A10 must be HIGH if more than one bank is active (i.e., must precharge all active banks)
PRE = PRECHARGE, ACT = ACTIVE, RA = Row Address, BA = Bank Address, AR = AUTOREFRESH
NOP commands are shown for ease of illustration; other valid commands may be possible after tRFC
DM, DQ and DQS signals are all Don't Care /High-Z for operations shown



Figure 35. Self Refresh Mode

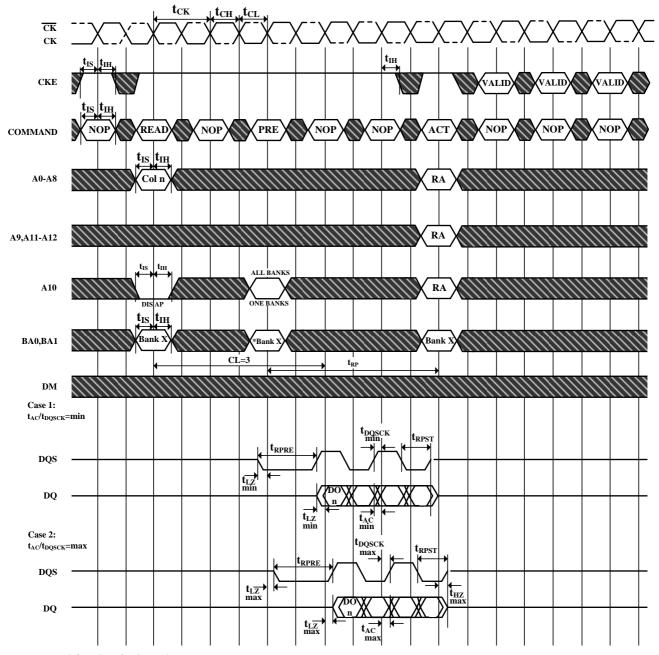


^{* =} Device must be in the All banks idle state prior to entering Self Refresh mode

^{*** =} tXSNR is required before any non-READ command can be applied, and tXSRD (200 cycles of CK) is required before a READ command can be applied.



Figure 36. Read without Auto Precharge



 $DO\ n = Data\ Out\ from\ column\ n$

Burst Length = 4 in the case shown

 $3 \ subsequent$ elements of Data Out are provided in the programmed order following DO n

DIS AP = Disable Autoprecharge

* = Don't Care , if A10 is HIGH at this point

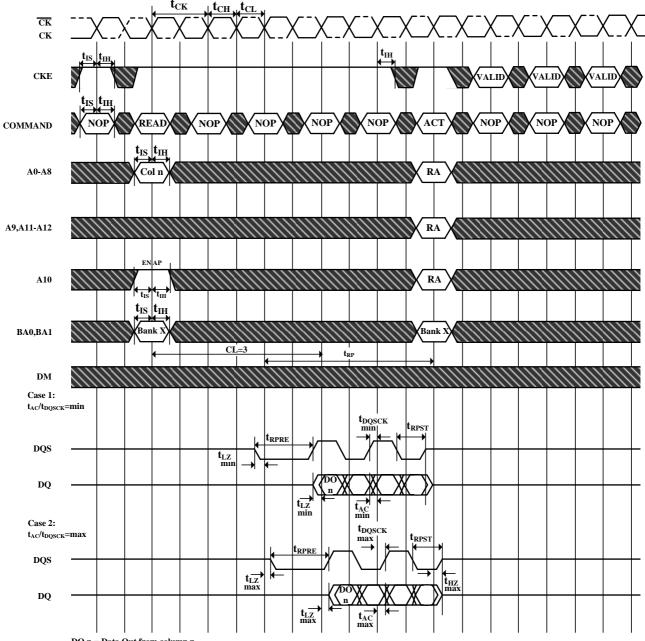
 $PRE = PRECHARGE, ACT = ACTIVE, RA = Row\ Address, BA = Bank\ Address, AR = AUTOREFRESH$

NOP commands are shown for ease of illustration; other commands may be valid at these times

Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks



Figure 37. Read with Auto Precharge



 $DO \ n = Data \ Out \ from \ column \ n$

Burst Length = 4 in the case shown

 $3\ subsequent\ elements\ of\ Data\ Out\ are\ provided\ in\ the\ programmed\ order\ following\ DO\ n$

EN AP = Enable Autoprecharge

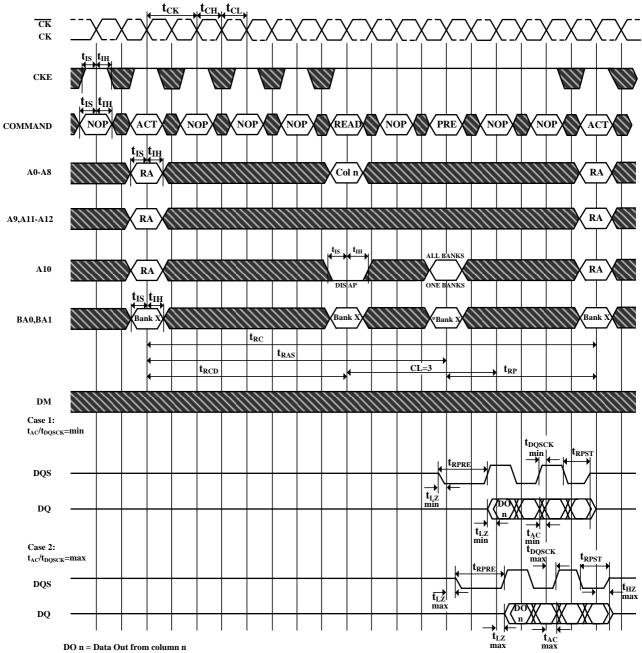
ACT = ACTIVE, RA = Row Address

NOP commands are shown for ease of illustration; other commands may be valid at these times

The READ command may not be issued until tRAP has been satisfied. If Fast Autoprecharge is supported, tRAP = tRCD, else the READ may not be issued prior to tRASmin (BL*tCK/2)



Figure 38. Bank Read Access



Burst Length = 4 in the case shown

3 subsequent elements of Data Out are provided in the programmed order following DO n

DIS AP = Disable Autoprecharge

* = Don't Care , if A10 is HIGH at this point

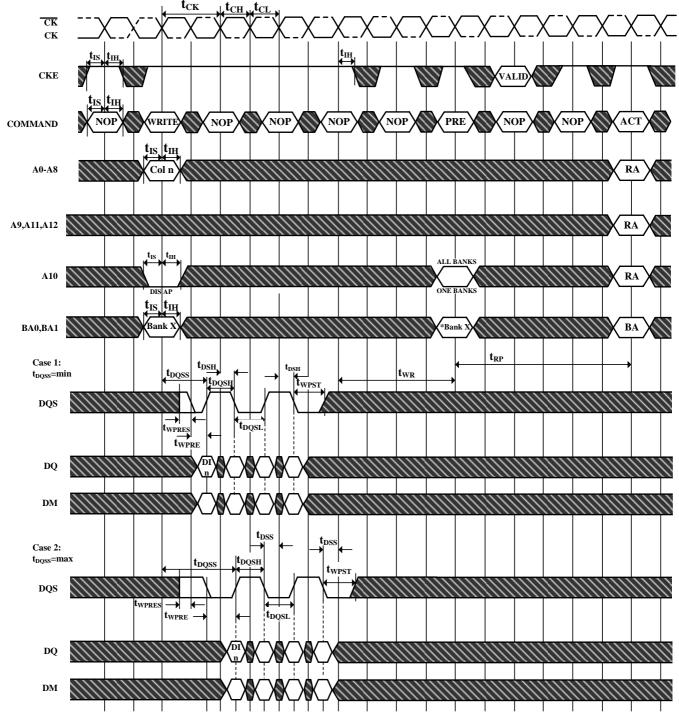
PRE = PRECHARGE, ACT = ACTIVE, RA = Row Address, BA = Bank Address

NOP commands are shown for ease of illustration; other commands may be valid at these times

Note that $tRCD > tRCD\ MIN\ so\ that\ the\ same\ timing\ applies\ if\ Autoprecharge\ is\ enabled\ (in\ which\ case\ tRAS)$ would be limiting)



Figure 39. Write without Auto Precharge



DI n = Data In from column n

Burst Length = 4 in the case shown

3 subsequent elements of Data In are provided in the programmed order following DI n

DIS AP = Disable Autoprecharge

*= Don't Care , if A10 is HIGH at this point

 $PRE = PRECHARGE, ACT = ACTIVE, RA = Row\ Address, BA = Bank\ Address, AR = AUTOREFRESH$

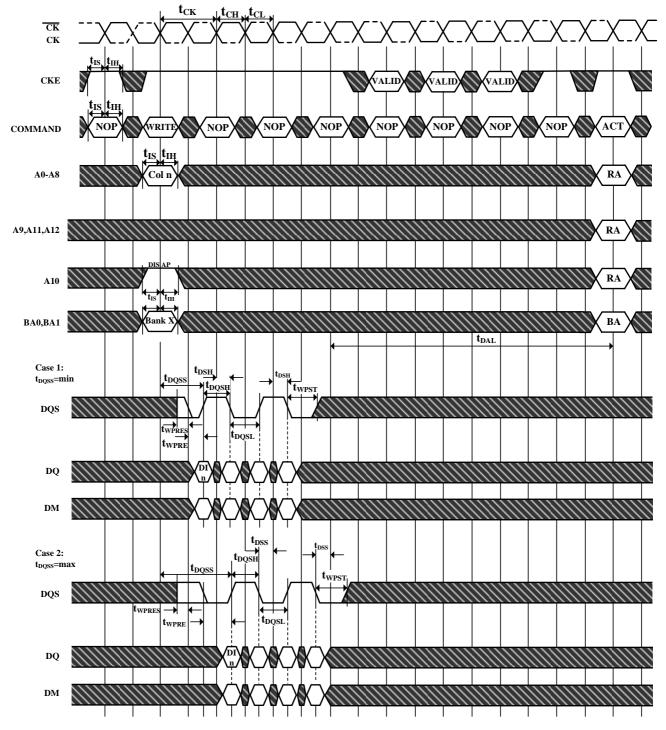
 $NOP\ commands\ are\ shown\ for\ ease\ of\ illustration;\ other\ commands\ may\ be\ valid\ at\ these\ times$

Although tDQSS is drawn only for the first DQS rising edge, each rising edge of DQS must fall within the $\pm\,25\%$ window of the corresponding positive clock edge

Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks

Don't Care

Figure 40. Write with Auto Precharge



DI n = Data In from column n

Burst Length = 4 in the case shown

 $3\ subsequent\ elements\ of\ Data\ Out\ are\ provided\ in\ the\ programmed\ order\ following\ DI\ n$

EN AP = Enable Autoprecharge

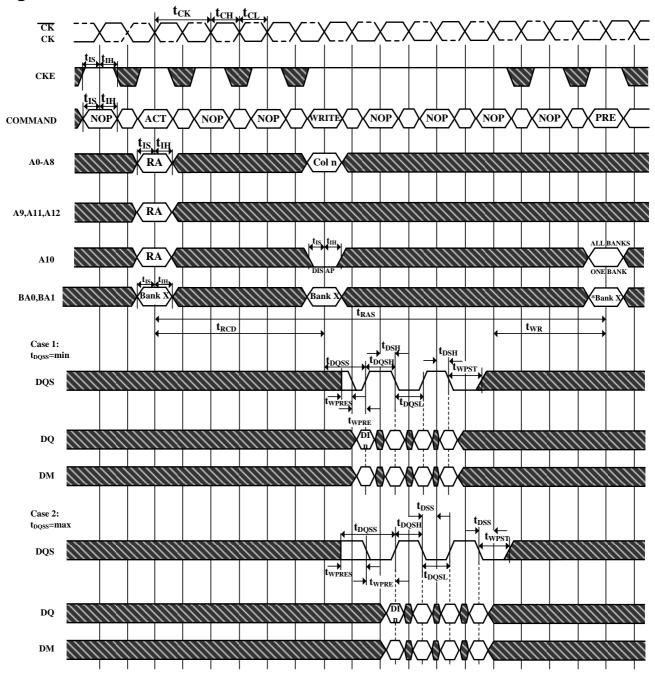
ACT = ACTIVE, RA = Row Address, BA = Bank Address

NOP commands are shown for ease of illustration; other commands may be valid at these times

Although tDQSS is drawn only for the first DQS rising edge, each rising edge of DQS must fall within the $\pm\,25\%$ window of the corresponding positive clock edge



Figure 41. Bank Write Access



DI n = Data In from column n

Burst Length = 4 in the case shown

3 subsequent elements of Data Out are provided in the programmed order following DI n

DIS AP = Disable Autoprecharge

*= Don't Care , if A10 is HIGH at this point

PRE = PRECHARGE, ACT = ACTIVE, RA = Row Address, BA = Bank Address

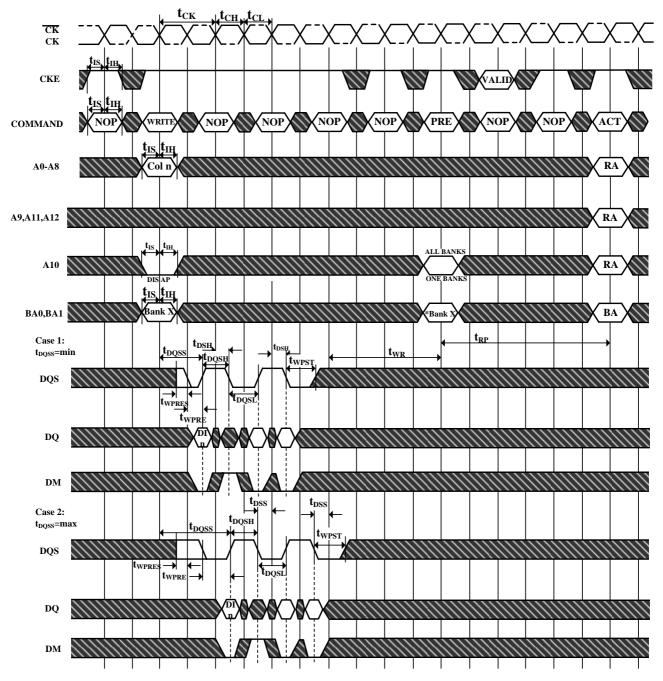
NOP commands are shown for ease of illustration; other commands may be valid at these times

Although tDQSS is drawn only for the first DQS rising edge, each rising edge of DQS must fall within the $\pm\,25\%$ window of the corresponding positive clock edge

 $\label{eq:command} \textbf{Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks}$

Don't Care

Figure 42. Write DM Operation



DI n = Data In from column n

Burst Length = 4 in the case shown

3 subsequent elements of Data In are provided in the programmed order following DI \boldsymbol{n}

DIS AP = Disable Autoprecharge

*= Don't Care , if A10 is HIGH at this point

PRE = PRECHARGE, ACT = ACTIVE, RA = Row Address, BA = Bank Address

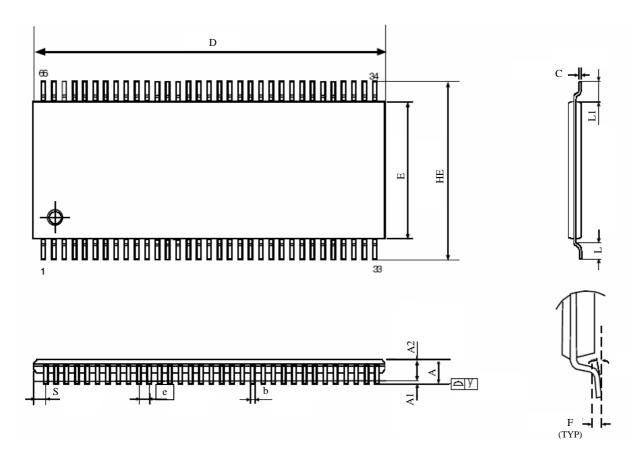
NOP commands are shown for ease of illustration; other commands may be valid at these times

Although tDQSS is drawn only for the first DQS rising edge, each rising edge of DQS must fall within the \pm 25% window of the corresponding positive clock edge

Precharge may not be issued before tRAS ns after the ACTIVE command for applicable banks



Figure 43. 66 Pin TSOP II Package Outline Drawing Information Units: mm



Symbol	Dimension in mm			Dimension in inch		
	Min	Nom	Max	Min	Nom	Max
Α			1.2			0.047
A1	0.05		0.2	0.002		0.008
A2	0.9	1.0	1.1	0.035	0.039	0.043
b	0.22	-	0.45	0.009		0.018
Ф		0.65			0.026	
С	0.095	0.125	0.21	0.004	0.005	0.008
D	22.09	22.22	22.35	0.87	0.875	0.88
Е	10.03	10.16	10.29	0.395	0.4	0.405
HE	11.56	11.76	11.96	0.455	0.463	0.471
L	0.40		0.75	0.016		0.03
L1		0.8			0.032	
F		0.25			0.01	
	0°		8°	0°		8°
S		0.71			0.028	
ΩУ			0.10			0.004

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